

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10629020	EZELL, R. WILLIAM
	Examiner Lee, Siu M	Art Unit 2611

SEARCHED

Class	Subclass	Date	Examiner
375	316	12/15/2006	Siu M. Lee
327	553	12/15/2006	Siu M. Lee
330	303	12/15/2006	Siu M. Lee

SEARCH NOTES

Search Notes	Date	Examiner
US-PGPUB	12/15/2006	Siu M. Lee
USPAT	12/15/2006	Siu M. Lee
USOCR	12/15/2006	Siu M. Lee
EPO	12/15/2006	Siu M. Lee
JPO	12/15/2006	Siu M. Lee
DERWENT	12/15/2006	Siu M. Lee
IBM_TDB	12/15/2006	Siu M. Lee
Discussed the application with Chieh Fan	12/15/2006	Siu M. Lee

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner